

# Memorandum

From: T. Prokscha To: 4275 Phone: Room: WLGA / U119 CC: E-mail: thomas.prokscha@psi.ch

LEM group

#### Results of the LEM $\mu$ E4-momentum scan, measured 21/Nov/2006 (Runs 1707-1779)

The purpose of this measurement is the determination of the muon moderation efficiency  $\varepsilon_{\mu}(p,\Delta p)$ as a function of beam momentum p and momentum width  $\Delta p$  at highest beam intensity. Knowing  $\varepsilon_{\mu}$ the  $\mu$ E4 intensity on LEM moderator can be estimated as a consistency check for  $\mu$ E4 beam transport: from the beam scanner data in 2005 we expect 85 M/mAs  $\mu^+$  on moderator at p = 28 MeV/c, 4.2-cm target E, at a total  $\mu^+$  rate of about 210 M/mAs. For the determination of  $\varepsilon_{\mu}(p,\Delta p)$  we measured the LEM  $e^+$ -rate as a function of beam momentum p for various settings of the  $\mu E4$  slits FS62 (horizontal slit in ASR62, allowing for the reduction of  $\Delta p/p$ ) and FS63 (horizontal and vertical). By fitting a simple model function to the data the momentum bite  $\Delta p/p$  of the  $\mu E4$  channel can be estimated. Within this model, the relative moderation efficiencies for different  $\Delta p/p$  can then be calculated and compared with the known result from  $\pi E3$ , where  $\varepsilon_{\mu} = 6.1 \cdot 10^{-5}$  has been found in 2001 for a N<sub>2</sub> moderator and  $\Delta p/p = 4\%$  (FWHM), see Appendix. This determination of  $\Delta p/p$  can be compared with independent  $\Delta p/p$ -measurements from p-tunes across the surface edge at 29.8 MeV/c.

**<u>Basics</u>**: The moderation efficiency  $\varepsilon_{\mu}$  is defined by

$$\varepsilon_{\mu} = N_{\mu}^{slow} / N_{\mu}^{moderator}.$$
 (1)

In Eq. 1  $N_{\mu}^{slow}$  is the number of epithermal  $\mu^+$  exiting the moderator, divided by the number  $N_{\mu}^{moderator}$  hitting the moderator.

For a monoenergetic beam the efficiency  $\varepsilon_{\mu}(p, \Delta p = 0)$  as a function of p can be approximated by a gaussian

$$\varepsilon_{\mu}(p) \propto e^{-\frac{(p-p_m)^2}{2\sigma_0^2}},\tag{2}$$

with the optimum momentum  $p_m$  and the "intrinsinsic" width  $\sigma_0$ , which are defined by the stopping distribution of the surface muon beam in the moderator. For an incoming  $\mu^+$  beam with gaussian momentum distribution with width  $\sigma_B$ , we can derive a simple expression for the slow- $\mu^+$  intensity  $I_{\mu}^{slow}(p)$  as a function of p by folding of the beam distribution I(p) with Eq. 2:

$$I_{\mu}^{slow}(p) \propto N_0 \cdot \frac{\sigma_0 \sigma_B}{\sqrt{\sigma_0^2 + \sigma_B^2}} \cdot e^{-\frac{(p-p_m)^2}{2(\sigma_0^2 + \sigma_B^2)}},$$
(3)

where  $\sigma_B = \Delta p/2.36$  ( $\Delta p$  denoting the FWHM). The efficiency is obtained normalizing Eq. 3 to the incoming beam rate, which is proportional to  $N_0 \cdot \sigma_B$ . This then gives for  $\varepsilon_{\mu}(p)$ 

$$\varepsilon_{\mu}(p) \propto \frac{\sigma_0}{\sqrt{\sigma_0^2 + \sigma_B^2}} \cdot e^{-\frac{(p-p_m)^2}{2(\sigma_0^2 + \sigma_B^2)}}.$$
(4)

#### **Procedure:**

- Meausure for slit settings (surface edge results from LB "New uE4 beamline 2, p.88):
  - FS61-500/FS62-555/FS63-500:  $\Delta p/p = 8.5\%$ , maximum intensity.
  - FS61-500/FS62-350/FS63-350:  $\Delta p/p = 7.0\%$ .
  - FS61-500/FS62-250/FS63-350:  $\Delta p/p = 6.5\%$ .
  - FS61-500/FS62-150/FS63-350:  $\Delta p/p = 5.6\%$ .
- Measure PosL and PosR positron rates (normalized to proton current) as a function of p for B\_parallel setup settings: WSXon\_13Oct2006\_300kV\_scale099.set.
- Quote p in "units" of  $p_0 = 28.0 \text{ MeV/c}$ .
- Measure  $e^+$  rates for Mirror on/off; substract Mirror-off rate from Mirror-on rates to obtain background (bkg) corrected positron rates. This bkg-corrected  $e^+$  are due to LE- $\mu^+$  decaying in the LEM sample region.
- Fit Eq. 3 to the data to determine  $\sigma_B$ . Fix  $\sigma_0$  to 1.7% of  $p_0$ , which is from a MCV3K [1] simulation of the  $\mu^+$  stopping distribution in the moderator, see Figs. 3,4.
- Use Eq. 4 to plot  $\varepsilon_{\mu}(p)$  together with the function for  $\Delta p/p = 4\%$  to determine  $\varepsilon_{\mu}(p_m)$  in  $\mu$ E4 at highest intensities.
- With this  $\varepsilon_{\mu}(p_m)$  estimate the rate of  $\mu^+$  impinging on the moderator and compare with the beam scanner data of 2005.

**<u>Results</u>**: The background corrected  $e^+$  rates and fits of Eq. 3 are shown in Fig. 1. With the fitted beam widths  $\sigma_B$  in Fig. 1 the relative moderation efficiencies  $\varepsilon_{\mu}$  are calculated according to Eq. 4 and are shown in Fig. 2. Comparing with the  $\Delta p/p = 4\%$ -data of 2001 we obtain

$$\varepsilon_{\mu}(\text{FS62} = 555) = \varepsilon_{\mu}(\Delta p/p = 4\%) \cdot \frac{0.396}{0.711}$$

$$= 6.1 \cdot 10^{-5} \cdot 0.56$$

$$= 3.4 \cdot 10^{-5}.$$
(5)

Determine now the  $\mu^+$  rate on moderator:

- Transport and detection efficiencies at 15 kV settings: transport moderator-sample  $\varepsilon_{Mod-Sample} = 0.32$  (HG Memo).  $e^+$  detection efficiency (PosL+PosR)  $\varepsilon_{e^+} = 0.25$  (TP Memo Geant3, 21/04/99).
- run 1565: bkg rates POSL, POSR = 22/mAs and 50/mAs, respectively, at  $p_m$ . run 1707: bkg rates POSL, POSR = 28/mAs and 62/mAs, respectively.

• bkg corrected rates:

run 1565:  $PosL+PosR = 232/mAs \implies 2900/mAs$  at moderator. run 1707:  $PosL+PosR = 230/mAs \implies 2900/mAs$  at moderator.

•  $\mu$ E4 rate  $I_{\mu}^{Mod}$  on Moderator:  $I_{\mu}^{Mod} = 2900/(3.4 \cdot 10^{-5})/\text{mAs} = 85 \text{ M/mAs}$ , in excellent agreement with beam scanner data.

## Summary:

Table 1: Summary of  $\pi E3$  and  $\mu E4$  results for  $\Delta p/p$ , moderation efficiencies  $\varepsilon_{\mu}$  for a s-N<sub>2</sub> moderator, and beam intensity  $I_{\mu}^{Mod}$  on muon moderator (3 × 3 cm<sup>2</sup>, "structured" Ag substrate), 4.2-cm target E. Rates linearly scale with target E thickness, which means that for the 6-cm target, the intensities are about 50% higher.  $\Delta p/p^{edge}$  means a determination of the momentum width by tuning across the  $\mu^+$  surface edge.

beam	$\Delta p/p$ [FWHM]	$\Delta p/p^{edge}$ [FWHM]	$\varepsilon_{\mu}(N_2)$	$I^{Mod}_{\mu}$
πE3, FS71O/U=200	4.0%	4.0%	$6.1 \cdot 10^{-5}$	
$\pi$ E3, open slits	7.0%	7.0%	$4.3 \cdot 10^{-5}$	8.7 M/mAs (LB35/97)
				$= 0.78 \cdot 11.1 \text{ M/mAs}$
				$(\varepsilon_{BC-Mod} = 0.78)$
μE4, FS62=555	9.4%	8.5%	$3.4 \cdot 10^{-5}$	85 M/mAs
μE4, FS62=350	8.1%	7.0%	$3.8 \cdot 10^{-5}$	
μE4, FS62=250	6.9%	6.5%	$4.3 \cdot 10^{-5}$	
μE4, FS62=150	5.9%	5.6%	$4.9 \cdot 10^{-5}$	

Excellement agreement is found for  $I_{\mu}^{Mod}$  between the beam scanner measurements in 2005 and LEM efficiency measurements. The momentum bite  $\Delta p/p^{edge}$  determined by the *p*-tune across the surface edge is always smaller than the one determined by the efficiency measurements. The  $\Delta p/p^{edge}$  data should be re-analyzed by fitting the edge – up to now  $\Delta p/p^{edge}$  is derived from a "geometrical" analysis. Additionally, the determination of  $\sigma_0$  – which determines the fit parameter  $\sigma_B$  and therefore  $\Delta p/p - in$  the MCV3K simulations is a simple approximation. Therefore, a deviation between both methods can be expected.



Figure 1: Background corrected positron rate (1/mAs) as a function of beam momentum. Fitted Eq. 3 to the data with a fixed intrinsic width  $\sigma_0 = 0.017$ .



Figure 2: Moderation efficiency  $\epsilon_{\mu}(p, dp)$  as a function of momentum p and momentum bite, calculated with Eq. 4.

![](_page_5_Figure_0.jpeg)

Figure 3: Simulated  $\mu^+$  stop density in a 10- $\mu$ m-thick s-Ar layer on a Ag substrate with different thicknesses. The different thickness are due to the "20- $\mu$ m deep V-shaped" surface of the Ag substrate [2]: at the bottom of the groove the thickness of the substrate is 115  $\mu$ m, at the top edge it is 135  $\mu$ m and the mean thickness is 125  $\mu$ m.

![](_page_6_Figure_0.jpeg)

Figure 4: Sum of simulated  $\mu^+$  stop densities of Fig. 3 in a 10- $\mu$ m-thick s-Ar layer on a Ag substrate with different thicknesses, fit by a gaussian. The relative width Sigma/Mean is 0.017.

## Appendix:

- $\pi$ E3 efficiency:
  - In 2001  $\Delta p/p = 4\%$  FWHM for FS71O/U = 200, NE13\_1 settings ("mixed mode"); see LB36/141 and "Beamlines" folder.
  - In 2001, run 1125: N<sub>2</sub> efficiency (from TOF TD-BC<sub>cl</sub>)  $\varepsilon_{\mu}^{uncorr} = 2340/10^8 \text{ BC}_{cl}$ , uncorrected for efficiencies; LB36/160.
  - Corrected efficiency  $\varepsilon_{\mu}(N_2) = \varepsilon_{\mu}^{uncorr} / \varepsilon_{det} = 6.1 \cdot 10^{-5}, \Delta p / p = 4\%$  FWHM.
  - Efficiencies:

total detection efficiency  $\varepsilon_{det} = 0.384 = 0.78 \cdot 0.60 \cdot 0.82 = \varepsilon_{BC-Mod} \cdot \varepsilon_{Mod-TD} \cdot \varepsilon_{TD}$ .

- \*  $\varepsilon_{BC-Mod}$  : transport beamcounter-moderator: 0.78 (TP memo 05/05/1998).
- geometric transmission from moderator to TD: 0.95 · 0.95 · 0.93 · 0.93 · 0.88 = 0.687 (grid1 x grid2 x mirror x mirror x TD-grid, see HG memo on Simion/MuTrack simulations;

grid1: 50  $\mu$ m wires, 1.0 mm distance, the same for grid2 (since 2001)

grid1: 25  $\mu$ m wires, 0.5 mm distance; grid2: 25  $\mu$ m, 1.0 mm distance (1999)).

- \* transport Mod-TD (15kV): 0.975 (HG memo).
- \* lifetime correction: 0.90 (TOF (15kV) = 230 ns).
- \*  $\varepsilon_{Mod-TD} = 0.60 = 0.687 \cdot 0.975 \cdot 0.90.$
- \*  $\varepsilon_{TD}$  : TD efficiency (2001): 0.82, LB36/135.
- Used Root macros (available in LEM SVN repository in analysis/root/macros, except setup\_treeviewer.C):
  - pscan.C: read LEM run summary files to extract relevant transport HV, beamline and scaler information; output is written to root file *p-scan\_lem06\_1707-1779.root*.
  - setup\_treeviewer.C: a file generated on the fly from TTreeViewer to save cuts and variables to be plotted.
  - getGraph.C and getGraphDifferences.C: two macros to copy plots from tree->Draw() in to TGraph objects; needed to subtract from the measured  $e^+$  rates the uncorrelated  $e^+$  background rate.

#### **References:**

- MCV3K: a Monte-Carlo simulation for the passage of particles through matter, M.W. Gladisch, W. Jakobs, K. Träger, T. Prokscha et al., Univ. Heidelberg/PSI, 1981-2001.
- [2] T. Prokscha, E. Morenzoni, C. David, A. Hofer, H. Glückler, L. Scandella, *Moderator gratings* for the generation of epithermal positive muons, Appl. Surf. Sc. **172**, 235 (2001).